

Search Notes



Application/Control No.

10/728,531

Examiner

Tae H. Yoon

Applicant(s)/Patent under Reexamination

LAI ET AL.

Art Unit

1714

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|---------|----------|
| 523 | 107 | 8-18-05 | EL |
| | 106 | | |
| 424 | 422 | | |
| ATD | | 1-6-06 | ZZ |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|-----------------|---------|------|
| EAST | 8-18-05 | ✓ |
| Inventor Search | 8-10-05 | |
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